

Notice of References Cited	Application/Control No. 10/572,595		Applicant(s)/Patent Under Reexamination YANO, KEIICHI	
	Examiner MEIYA LI		Art Unit 2811	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0188696	09-2004	Hsing Chen et al.	257/099
*	B	US-6,614,103	09-2003	Durocher et al.	257/678
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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